Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/663,812	CHEN ET AL.	
Examiner	Art Unit	
Brian L. Albertalli	2655	•

SEARCHED			
Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH N		 ')
	DATE	EXMR
Updated EAST Search (See Printout)	7/7/2005	ВА
IEEE Search (index with morpheme) (index with syllable)	7/7/2005	ВА
ACM Search (index with morpheme) (index with syllable)	7/7/2005	ВА